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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/760,339	CHAPPEL ET AL.	
Examiner	Art Unit	
Scott L. Jarrett	3623	

SEARCHED			
Class	Subclass	Date	Examiner
705	7, 8, 9, 10	10/15/2004	SJ
705	37, 400	10/15/2004	SJ
			SALE
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	— -)
	DATE	EXMR
EAST: -Keyword: Boehm, COCOMO, IFPUG, software process metrics, measurement, assesment, performance, project management	10/14/2004	SJ
EAST -Keyword: project plan, assesment, IEEE 1998-830, software requirements, specification, process, project metrics	10/14/2004	SJ
Google.com - Keyword: software requirement volatility, stability, requirements engineering, software metrics, measurement	10/14/2004	SJ
IEEE - Keyword: software requirement engineering, process metrics, measurement, requirements stability, volatility	10/14/2004	SJ